

STP5N105K5

N-channel 1050 V, 2.9 Ω typ., 3 A MDmesh™ K5 Power MOSFET in a TO-220 package

Datasheet - production data

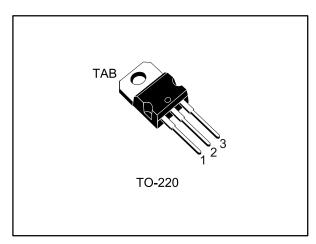
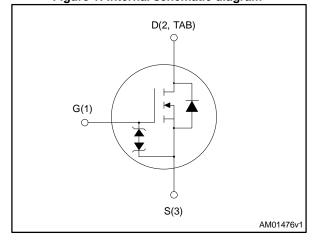


Figure 1: Internal schematic diagram



Features

Order code	V _{DS}	R _{DS(on)} max.	ΙD	Ртот
STP5N105K5	1050 V	3.5 Ω	3 A	85 W

- Worldwide best FOM (figure of merit)
- Ultra low gate charge
- 100% avalanche tested
- Zener-protected

Applications

Switching applications

Description

This N-channel Zener-protected Power MOSFET is designed using ST's revolutionary avalancherugged very high voltage MDmesh™ K5 technology, based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance, and ultra-low gate charge for applications which require superior power density and high efficiency.

Table 1: Device summary

Order code	Marking	Package	Packaging
STP5N105K5	5N105K5	TO-220	Tube

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STP5N105K5 Electrical ratings

1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit	
V _{GS}	Gate- source voltage	± 30	V	
I _D	Drain current (continuous) at T _C = 25 °C 3			
ΙD	Drain current (continuous) at T _C = 100 °C	2	Α	
I _{DM} ⁽¹⁾	Drain current (pulsed)	12	Α	
Ртот	Total dissipation at T _C = 25 °C	85	W	
I _{AR}	Max current during repetitive or single pulse avalanche	1	Α	
Eas	Single pulse avalanche energy (starting T _J = 25 °C, I _D =I _{AS} , V _{DD} = 50 V)	85	mJ	
dv/dt (2)	Peak diode recovery voltage slope	4.5	V/ns	
dv/dt (3)	MOSFET dv/dt ruggedness	50	V/ns	
Tj	Operating junction temperature	FF to 150	°C	
T _{stg}	Storage temperature	- 55 to 150		

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	1.47	°C/W
R _{thj-amb}	Thermal resistance junction-amb max	62.5	°C/W

⁽¹⁾Pulse width limited by safe operating area

 $^{^{(2)}}I_{SD} \le 3 \text{ A, di/dt} \le 100 \text{ A/}\mu\text{s, } V_{DS(peak)} \le V_{(BR)DSS}$

 $^{^{(3)}}$ V_{DS} $\leq 840 \text{ V}$

Electrical characteristics STP5N105K5

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified).

Table 4: On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	V _{GS} = 0, I _D = 1 mA	1050			٧
	Zara gata valtaga drain	V _{GS} = 0, V _{DS} = 1050 V			1	μΑ
IDSS	Zero gate voltage drain current	V _{GS} = 0, V _{DS} = 1050 V, Tc=125 °C			50	μΑ
Igss	Gate body leakage current	$V_{DS} = 0$, $V_{GS} = \pm 20 \text{ V}$			±10	μΑ
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 100 \mu A$	3	4	5	V
R _{DS(on)}	Static drain-source on- resistance	V _{GS} = 10 V, I _D = 1.5 A		2.9	3.5	Ω

Table 5: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance	.,, ,	-	210	-	pF
Coss	Output capacitance	V _{DS} =100 V, f=1 MHz, V _{GS} =0	-	16	-	pF
C _{rss}	Reverse transfer capacitance	VG5-0	-	0.5	-	pF
C _{o(tr)} ⁽¹⁾	Equivalent capacitance time related	V 0 V 0 to 940 V	-	26	-	pF
C _{o(er)} ⁽²⁾	Equivalent capacitance energy related	$V_{GS} = 0$, $V_{DS} = 0$ to 840 V	-	10	-	pF
R_{G}	Intrinsic gate resistance	f = 1MHz open drain	-	9	-	Ω
Qg	Total gate charge	$V_{DD} = 840 \text{ V}, I_D = 3 \text{ A}$	-	12.5	-	nC
Qgs	Gate-source charge	V _{GS} =10 V	-	2	-	nC
Q_{gd}	Gate-drain charge	Figure 16: "Gate charge test circuit"	-	9.5	-	nC

Notes:

Table 6: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	$V_{DD} = 525V, I_{D} = 1.5 A, R_{G} = 4.7 \Omega,$	-	15.5	-	ns
t _r	Rise time	V _{GS} =10 V	ı	8.5	ı	ns
t _{d(off)}	Turn-off delay time	Figure 18: " Unclamped inductive load test circuit"	1	31	1	ns
t _f	Fall time		-	24	1	ns

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 $^{^{(1)}}$ Time related is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

 $^{^{(2)}}$ Energy related is defined as a constant equivalent capacitance giving the same stored energy as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 7: Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD}	Source-drain current		-		3	А
I _{SDM}	Source-drain current (pulsed)				12	Α
V _{SD} ⁽¹⁾	Forward on voltage	I _{SD} = 3 A, V _{GS} =0	1		1.5	V
t _{rr}	Reverse recovery time	I _{SD} = 3 A, V _{DD} = 60 V	-	400		ns
Qrr	Reverse recovery charge	di/dt = 100 A/µs, Figure 17: " Test circuit for inductive load switching and diode recovery times"	-	2.3		μC
I _{RRM}	Reverse recovery current		-	12		Α
t _{rr}	Reverse recovery time	I _{SD} = 3 A,V _{DD} = 60 V di/dt=100 A/µs,	-	560		ns
Qrr	Reverse recovery charge	Tj=150 °C Figure 17: " Test circuit for inductive	-	3.1		μC
I _{RRM}	Reverse recovery current	load switching and diode recovery times"	-	11		А

Notes:

Table 8: Gate-source Zener diode

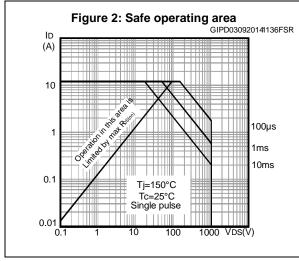
Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
V _(BR) GSO	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{mA}, I_{D}=0$	30	-	-	V

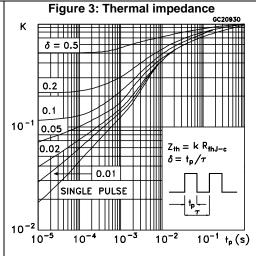
The built-in back-to-back Zener diodes have specifically been designed to enhance the device's ESD capability. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

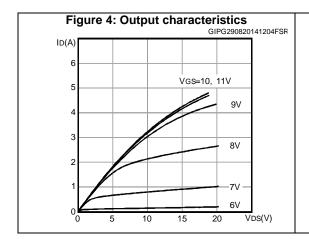


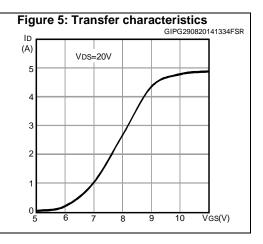
 $^{^{(1)}}$ Pulsed: pulse duration = 300 μ s, duty cycle 1.5%

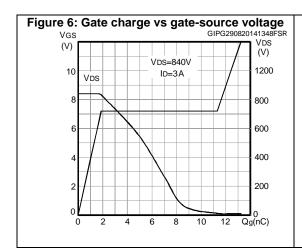
2.1 Electrical characteristics (curves)



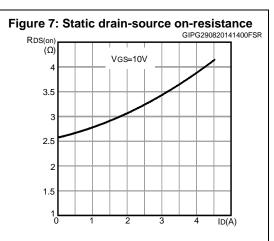




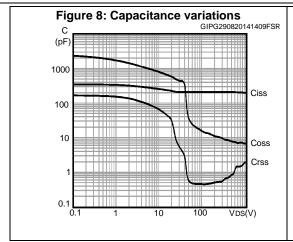




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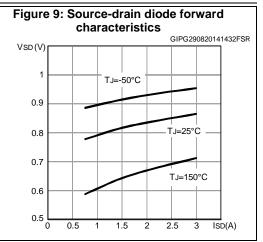
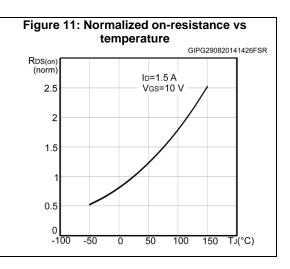
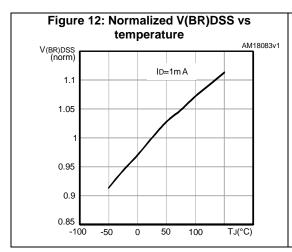
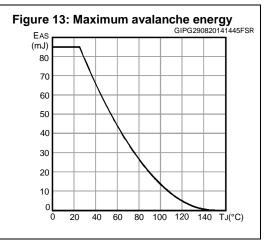
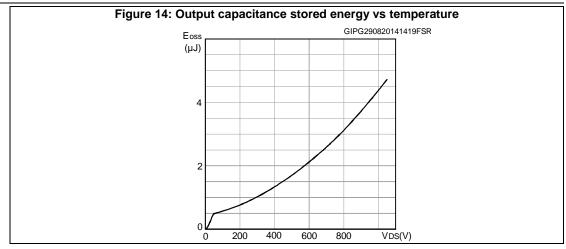


Figure 10: Normalized gate threshold voltage vs temperature AM18082v1 VGS(th) ID=100 μ A 1.2 1.1 0.9 0.8 0.7 0.6 0.5 0.4 -50 50 150 TJ(°C)



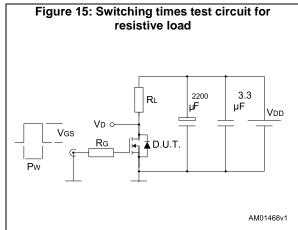


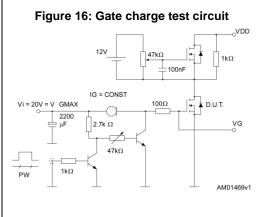


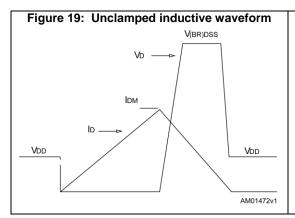


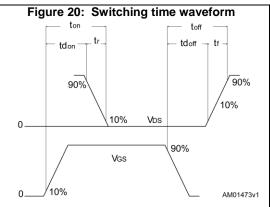
STP5N105K5 Test circuits

3 Test circuits









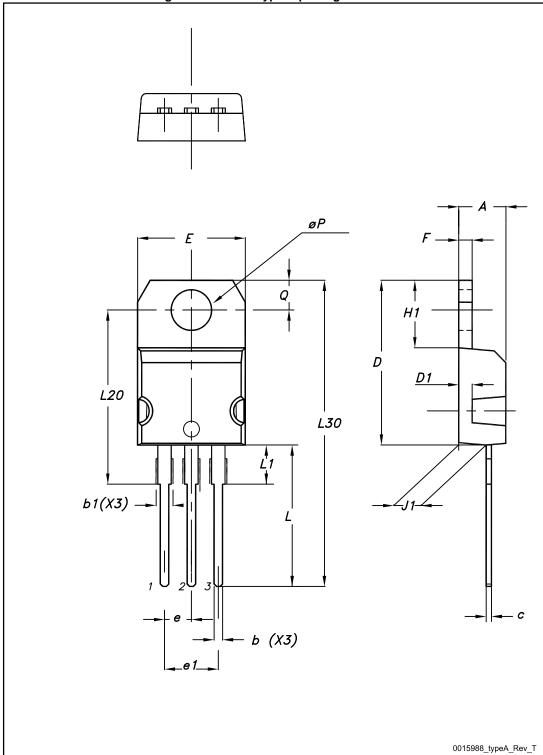
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

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4.1 TO-220 package mechanical data

Figure 21: TO-220 type A package outline



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Table 9: TO-220 type A mechanical data

Table 9: 10-220 type A mechanical data				
Dim.		mm		
Diiii.	Min.	Тур.	Max.	
А	4.40		4.60	
b	0.61		0.88	
b1	1.14		1.70	
С	0.48		0.70	
D	15.25		15.75	
D1		1.27		
E	10		10.40	
е	2.40		2.70	
e1	4.95		5.15	
F	1.23		1.32	
H1	6.20		6.60	
J1	2.40		2.72	
L	13		14	
L1	3.50		3.93	
L20		16.40		
L30		28.90		
ÆP	3.75		3.85	
Q	2.65		2.95	

STP5N105K5 Revision history

5 Revision history

Table 10: Document revision history

Date	Revision	Changes
17-Jul-2014	1	First release.
03-Sep-2014	2	Document status promoted from preliminary to production data. Added Section 3.1: "Electrical characteristics (curves)" Minor text changes.
15-Oct-2014	3	Updated Figure 6: "Gate charge vs gate-source voltage"and Figure 8: "Capacitance variations"

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